CE EMC

TEST REPORT

For

ETX Board

Model: ETX-821

Trade Name: AAEON

Issued to

AAEON Technology Inc. 5F, No.135, Lane 235, Pao Chiao Rd., Hsin-Tien City, Taipei, Taiwan, R.O.C.

Issued by

Compliance Certification Services Inc. Hsintien Lab.



No. 165, Chunghsen Road, Hsintien City Taipei Hsien, Taiwan TEL: (02) 2217-0894

FAX: (02) 2217-1029



Date of Issue: August 08, 2005

Note: This report shall not be reproduced except in full, without the written approval of Compliance Certification Services Inc. Ltd. This document may be altered or revised by Compliance Certification Services Inc. personnel only, and shall be noted in the revision section of the document.

TABLE OF CONTENTS

1	TEST RESULT CERTIFICATION	3
2	EUT DESCRIPTION	4
3	TEST METHODOLOGY	5
	3.1 EUT SYSTEM OPERATION	5
4	SETUP OF EQUIPMENT UNDER TEST	6
5	FACILITIES AND ACCREDITATIONS	8
	5.1 FACILITIES	8
6	INSTRUMENT AND CALIBRATION	9
	6.1 MEASURING INSTRUMENT CALIBRATION	
7	LINE CONDUCTED & RADIATED EMISSION TEST	12
	7.1 LIMIT	12 13
	TELECOMMUNICATION PORT	
	7.4 TEST PROCEDURE OF RADIATED EMISSION	
8	POWER HARMONICS TEST	19
9	POWER VOLTAGE FLUCTUATION / FLICKER TEST	21
10	0 ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST	23
	1 RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST	
12	2 FAST TRANSIENTS/BURST IMMUNITY TEST	29
13	3 SURGE IMMUNITY TEST	31
14	4 CONDUCTED DISTRBANCE/INDUCED RADIO-FREQUENCY FIELD IMMUNITY TEST	33
15	5 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST	35
10	6 VOLTAGE DIPS / SHORT INTERRUPTIONS	37
A	APPENDIX I - PHOTOGRAPHS OF TEST SETUP	39
A	APPENDIX II – TEST RESULT OF EN 61000-3-3	46
A	APPENDIX III - TEST RESULT OF FINAL DATAS	47

1 TEST RESULT CERTIFICATION

Applicant: AAEON Technology Inc.

5F, No.135, Lane 235, Pao Chiao Rd., Hsin-Tien City,

Date of Issue: August 08, 2005

Taipei, Taiwan, R.O.C.

Manufacturer: AAEON Technology Inc.

5F, No.135, Lane 235, Pao Chiao Rd., Hsin-Tien City,

Taipei, Taiwan, R.O.C.

Equipment Under Test: ETX Board

Trade Name: AAEON

Model: ETX-821

Detailed EUT Description: See Item 2 of this report

Date of Test: July 30, 2005 ~ August 03, 2005

Applicable Standard	Class/Limit/Criterion	Test Result		
EN 55022: 1998 + A1: 2000 + A2: 2003	Class A	No non-compliance noted		
EN 61000-3-2: 2000	Class D	N/A		
EN 61000-3-3: 1995 + A1: 2001	Limit	No non-compliance noted		
EN 55024:1998 + A1: 2001 + A2: 2003, including	ng			
IEC 61000-4-2: 1995 + A1: 1998 + A2: 2000	Criterion B	No non-compliance noted		
IEC 61000-4-3: 2002 + A1: 2002	Criterion A	No non-compliance noted		
IEC 61000-4-4: 1995 + A1: 2000 + A2: 2001	Criterion B	No non-compliance noted		
IEC 61000-4-5: 1995 + A1: 2000	Criterion B	No non-compliance noted		
IEC 61000-4-6: 1996 + A1: 2000	Criterion A	No non-compliance noted		
IEC 61000-4-8: 1993 + A1: 2000	Criterion A	N/A		
IEC 61000-4-11: 1994 + A1: 2000	Criterion B/C/C	No non-compliance noted		
Deviation from Applicable Standard				
At the customers' request, we adopt the above standards.				

The above equipment was tested by Compliance Certification Services Inc. for compliance with the requirements set forth in the EMC Directive 89/336/EMC and the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Approved by:

Reviewed by:

David Wang

Manager of Hsintien Laboratory

Compliance Certification Services Inc.

Vince Chiang

Assistant Manager of Hsintien Laboratory Compliance Certification Services Inc.

Page 3 Total Page: 47

Rev. 00

2 EUT DESCRIPTION

Product	ETX Board
Trade Name	AAEON
Model	ETX-821
Housing Type	N/A
Power Adaptor Power Rating	3.3VDC/ 5VDC from Host PC
AC Power During Test	230VAC / 50Hz to Host PC Power Supply
Power Supply Manufacturer	Seventeam
Power Supply Model Number	ST-300HLP
AC Power Cord Type	Unshielded, 1.8m (Detachable) to Host PC Power Supply
OSC/Clock Frequencies	32.768kHz; 14.31818MHz; 25MHz; 24.576MHz

Date of Issue: August 08, 2005

I/O PORT OF EUT

I/O PORT TYPE	Q'TY	TESTED WITH

Note: Client consigns only one model sample (Model Number is ETX-821) to test.

Page 4 Rev. 00

3 TEST METHODOLOGY

3.1 EUT SYSTEM OPERATION

- 1. Windows XP boots system.
- 2. Run Emctest.exe to activate all peripherals and display "H" pattern on monitor screen.

Date of Issue: August 08, 2005

- 3. Run Winemc.exe and choose (C:/ \ E:/ \ F:/ \ G:/ \ H:/) to test USB 2.0 port.
- 4. Run Winemc.exe and choose media player to play music.
- 5. Press the start menu, select executive and type ping 192.168.0.2 –t (EUT), ping 192.168.0.1 –t (Server Notebook).

Note: Test program is self-repeating throughout the test.

3.2 DECISION OF FINAL TEST MODE

1. The following test mode(s) were scanned during the preliminary test:

Mode:

1. NORMAL MODE

2. After the preliminary scan, the following test mode(s) was found to produce the highest emission level.

Conduction: Mode 1

Radiation: Mode 1

Then, the EUT configuration and cable configuration of the above highest emission mode was chosen for all final test items.

Page 5 Rev. 00

4 SETUP OF EQUIPMENT UNDER TEST

Setup Diagram

See test photographs attached in Appendix I for the actual connections between EUT and support equipment.

Date of Issue: August 08, 2005

Support Equipment

Host PC Devices:

No	Equipment	Model #	Serial #	FCC ID / BSMI ID	Trade Name
1.	CPU (1.3GHz)	Celeron M-1.3GHz	N/A	N/A	Intel
2.	Memory (256MB)	DDR266	N/A	N/A	KINGSTON
3.	Power Supply	ST-300HLP	N/A	N/A	Seventeam
4.	HDD (40GB)	VAM5JJ0	N/A	N/A	Maxtor

Page 6 Rev. 00

Peripherals Devices:

No	Equipment	Model	Serial No.	FCC ID / BSMI ID	Trade Name	Data Cable	Power Cord
1.	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSys	Shielded, 2.0m	N/A
2.	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSys	Shielded, 2.0m	N/A
3.	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSys	Shielded, 2.0m	N/A
4.	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSys	Shielded, 2.0m	N/A
5.	PS/2 Mouse	M071KC	443029525	DoC BSMI: R41108	DELL	Shielded, 1.8m	N/A
6.	PS/2 Keyboard	SK-8110	N/A	DoC BSMI: T3A002	DELL	Shielded, 1.8m	N/A
7.	Player	RQ-L11LT	N/A	BSMI ID: 3912A162	Panasonic	Unshielded, 1.8m	N/A
8.	Ear. / Mic.	MSB301	N/A	N/A	e-Sense	Unshielded, 1.8m	N/A
9.	Printer	C20SX	N/A	BSMI ID: 3902E004	EPSON	Shielded, 1.8m	Unshielded, 1.8m
10.	Modem	5JEG4033MKO	N/A	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.8m	Unshielded, 1.8m
11.	Printer	C60	N/A	BSMI ID: 3902E006	EPSON	Shielded, 1.8m	Unshielded, 1.8m
12.	Modem	1414	N/A	IFAXDM1414	ACEEX	Shielded, 1.8m	Unshielded, 1.8m
13.	Monitor	710V	GS17H9NXA05 853A	DoC BSMI: R33475	SAMSUNG	Shielded, 1.8m with two cores	Unshielded, 1.8m
14.	Modem	5JEG4033MKO	N/A	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.8m	Unshielded, 1.8m
15.	Modem	5JEG4033MKO	N/A	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.8m	Unshielded, 1.8m
16.	Server Notebook	2659-FT1	AK-VHXOH 02/10 C	ANOPSIWLIV	IBM	Unshielded, 20m	Unshielded, 1.8m with a core

Date of Issue: August 08, 2005

Note: All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

Grounding: Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.

Page 7 Rev. 00

5 FACILITIES AND ACCREDITATIONS

5.1 FACILITIES

All measurement facilities used to collect the measurement data are located at CCS Taiwan Hsintien Lab at No. 165, Chunghsen Road, Hsintien City, Taipei Hsien, Taiwan.

Date of Issue: August 08, 2005

The measurement facilities are constructed in conformance with the requirements of CISPR 16-1, ANSI C63.4 and other equivalent standards.

5.2 LABORATORY ACCREDITATIONS AND LISTINGS

The test facilities used to perform Electromagnetic compatibility tests are registered or accredited by the organizations listed in the following table which includes the recognized scope specifically.

Country	Agency	Scope of Accreditation	Logo
USA A2LA		CFR 47, FCC Part 15/18 using ANSI 63.4; AS/NZS 3548; VCCI V3; CNS 13438; CNS 13439; CNS 13783; CNS 14115; CISPR 11/EN 55011; CISPR 14-1/EN 55014-1; CISPR 15/EN 55015; CISPR 22/EN 55022; EN 50081-1/EN 61000-6-3; EN 50082-1/EN 61000-6-4; IEC/EN 61000-4-2, IEC/EN 61000-4-3, IEC/EN 61000-4-4, IEC/EN 61000-4-5, IEC/EN 61000-3-2, IEC/EN 61000-3-3; CISPR 24/EN 55024; CISPR 14-2/EN 55014-2; EN 50081-2/EN 61000-6-1; EN 50082-2/EN 61000-6-2.	ACCREDITED
USA	FCC	3/10 meter Open Area Test Sites to perform FCC Part 15/18 measurements	FC 250366
Japan	VCCI	3/10 meter Open Area Test Sites and Line Conducted Test Room to perform conducted/radiated measurements	VCCI R-1434/1630~4 C-1511/1882
Norway	NEMKO	EN 50081-1/2, EN 50082-1/2, IEC 61000-6-1/2/3/4, EN 50091-2, EN 50130-4, EN 55011, EN 55013, EN 55014-1/2, EN 55015, EN 55022, EN 55024, EN 61000-3-2/3, EN 61326-1, IEC 61000-4-2/3/4/5/6/8/11, Cispr 16-1/2/3/4	ELA 103
Taiwan	CNLA	47 CFR FCC Part 15 Subpart B, EN 61000-3-2, EN 61000-3-3, CNS 13439, CNS 13783-1, CNS 13438, AS/NZS 3548, VCCI, CNS 13022-1/2/3, EN 55022, EN 55013, EN 55014-1, EN 61000-4-2/3/4/5/6/8/11, ENV 50204, ENV 50141, ENV 50142	1108 ILAC MRA
Taiwan BSMI CNS 13438, CNS 13		CNS 13438, CNS 13783-1, CNS 13439	SL2-IN-E-0005 SL2-A1-E-0005 SL2-R1-E-0005 SL2-R2-E-0005
Canada	Industry Canada	RSS212, Issue 1	Canada IC 5742

Note: No part of this report may be used to claim or imply product endorsement by CNLA, A2LA or other government agency.

Page 8 Rev. 00

6 INSTRUMENT AND CALIBRATION

6.1 MEASURING INSTRUMENT CALIBRATION

The measuring equipment utilized to perform the tests documented in this report has been calibrated once a year or in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

Date of Issue: August 08, 2005

6.2 TEST AND MEASUREMENT EQUIPMENT

The following list contains measurement equipment used for testing. The equipment conforms to the requirement of CISPR 16-1, ANSI C63.2 and. other required standards.

Calibration of all test and measurement, including any accessories that may effect such calibration, is checked frequently to ensure the accuracy. Adjustments are made and correction factors are applied in accordance with the instructions contained in the respective manual.

Equipment Used for Emission Measurement

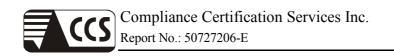
Open Area Test Site # I						
EQUIPMENT	MFR	MODEL	SERIAL NUMBER	CAL. DUE		
SITE NSA	CCS	I Site	N/A	09/17/2005		
MEASURE RECEIVER	SCHAFFNER	SCR3501	338	06/27/2006		
SPECTRUM ANALYZER	ADVANTEST	R3132	120900008	No Calibration Required		
ANTENNA	SCHAFFNER	CBL 6112B	2809	09/24/2005		
AMPLIFIER	SCHAFFNER	CPA9231A	3626	10/08/2005		
CABLE	BELDEN	9913	N-TYPE #I2	02/18/2006		
ATTENUATOR	MCL	UNAT-6	AT06-3	10/08/2005		
THERMO- HYGRO METER	TFA	N/A	NO.2	11/09/2005		
DECOUPLING NETWORK	FCC	F-201-DCN-5-6MM	22 \ 24	09/07/2005		

Note: The measurement uncertainty is less than +/- 3.36dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.

Conducted Emission Test Site # A							
EQUIPMENT	MFR	MODEL	SERIAL NUMBER	CAL. DUE			
TEST RECEIVER	R&S	ESHS20	840455/006	02/17/2006			
LISN (EUT)	LISN (EUT) SCHWARZBECK		8127382	01/03/2006			
LISN	SOLAR	8012-50-R-24-BNC	8305114	01/03/2006			
BNC CABLE	MIYAZAKI	5D-FB	BNC A1	01/28/2006			
THERMO- HYGRO METER	I		9303-1	03/02/2006			

Note: The measurement uncertainty is less than +/- 2.83dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.

Page 9 Rev. 00



Power Harmonic & Voltage Fluctuation/Flicker Test Site (EN 61000-3-2&-3-3)							
Manufacturer/Type	Model No.	Serial No.	Cal. Due				
Schaffner / Signal Conditioning Unit	CCN 1000-1	72122	12/05/2005				
Schaffner / 5KVA AC Power Source	NSG 1007	55131	No Calibration Required				
Protronix / Digital Power Meter	1201	201091	08/31/2005				

Equipment Used for Immunity Measurement

ESD Test Site (EN 61000-4-2)						
Manufacturer/Type Model No. Serial No. Cal. Due						
Schaffner / ESD Simulator	NSG 438	129	04/20/2006			
Sato / Aneroid Barometer	7610-20	89090	09/07/2005			
TOP / Thermo-Hygro meter	HA-202	9303-1	03/02/2006			

Radiated Electromagnetic Field Immunity Test Site (EN 61000-4-3)						
Manufacturer/Type	Model No.	Serial No.	Cal. Due			
Calibration of Field	Chamber#RS	RS3H-7 / RS3V-7	07/01/2006			
Agilent / Signal Generator	E4421B	MY43350597	05/16/2006			
AR / Electric Field Probe	FP6001	305650	02/03/2006			
Boonton / RF Voltmeter	9200B	328001AE	02/23/2006			
BNC / Function Generator	625A	25451	02/17/2006			
AR / Amplifier	100W1000M1	17564	No Calibration Required			
Werlatone Inc. / Direction Coupler	C2630	4121	No Calibration Required			
Frankonia / Broadband Antenna	BTA-M	030001M	No Calibration Required			
TOP / Thermo-Hygro meter	HA-202	9303-2	03/02/2006			

Fast Transients/Burst Test Site (EN 61000-4-4)						
Manufacturer/Type Model No. Serial No. Cal.						
Schaffner / EFT Generator	BEST EMC V2.3	200031A024SC	11/09/2005			
Schaffner / Capacitive Clamp	N/A	N/A	No Calibration Required			

Page 10 Rev. 00

Surge Immunity Test Site (EN 61000-4-5)						
Manufacturer/Type Model No. Serial No. Cal. Due						
Schaffner / Surger Generator	BEST EMC V2.3	200031A024SC	11/09/2005			
Schaffner / Signal and Data Lines Coupling Network CDN118		19328	No Calibration Required			

CS test (EN 61000-4-6)							
Manufacturer/Type	Model No.	Serial No.	Cal. Due				
Schaffner / RF Generator	NSG 2070-1	1061	08/02/2005				
Schaffner / CDN	CDN M316	19600	08/02/2005				
Schaffner / CDN	CDN M216	19294	08/02/2005				
Schaffner / EM Clamp	KEMZ 801	19227	02/23/2006				
Schaffner / CDN	CDN A800	17885	08/02/2005				
Schaffner / CDN	CDN T002	15881	01/13/2006				
FCC / CDN	FCC-801-T8-RJ45	04025	06/23/2006				
Schaffner / Attenuator	INA2070-1	2061	No Calibration Required				
FCC / CDN	FCC-801-T4-RJ45	04031	08/19/2005				

Power Frequency Magnetic Field Immunity test (EN 61000-4-8)							
Manufacturer/Type	Model No.	Model No. Serial No.					
Schaffner / Induction Coil Interface	INA 21141	6009	No Calibration Required				
Schaffner / 5KVA AC Power Source	NSG 1007	55131	No Calibration Required				
CHY/ TRMS Clamp Meter	932C	2K0900285	10/12/2005				
Sypris / Magnetic Field Meter	4080	0247	01/19/2006				

Voltage Dips/Short Interruption and Voltage Variation Immunity test (EN 61000-4-11)							
Manufacturer/Type	Model No.	Serial No.	Cal. Due				
Schaffner / Dips/Interruption/Variations Tester	BEST EMC V2.3	200031A024SC	11/09/2005				
Protronix / Digital Power Meter	1201	201091	08/31/2005				

Page 11 Rev. 00

7 LINE CONDUCTED & RADIATED EMISSION TEST

Date of Issue: August 08, 2005

7.1 LIMIT

Maximum permissible level of Line Conducted Emission

FREQUENCY	Class A ((dBuV)	Class B (dBuV)		
(MHz)	Quasi-peak Average		Quasi-peak	Average	
0.15 - 0.5	79	66	66 - 56	56 - 46	
0.50 - 5.0	73	60	56	46	
5.0 - 30.0	73	60	60	50	

Note: The lower limit shall apply at the transition frequency.

<u>Maximum permissible level of Common Mode Conducted Emission</u> (<u>Telecommunication Ports</u>)

CLASS A

FREQUENCY	Voltage Limit (dBuV)		Current Limit (dBuA)		
(MHz)	Quasi-peak Average		Quasi-peak	Average	
0.15 - 0.5	97 – 87	84 - 74	53 – 43	40 – 30	
0.5 - 30.0	87	74	43	30	

CLASS B

FREQUENCY	Voltage Limit (dBuV)		Current Limit (dBuA)		
(MHz)	Quasi-peak Average		Quasi-peak	Average	
0.15 - 0.5	84 - 74	74 - 64	40 – 30	30 – 20	
0.5 - 30.0	74	64	30	20	

Note: The lower limit shall apply at the transition frequency.

Maximum permissible level of Radiated Emission measured at 10 meter

FREQUENCY	Class A (dBuV/m)	Class B (dBuV/m)		
(MHz)	Quasi-peak	Quasi-peak		
30 - 230	40	30		
230 - 1000	47	37		

Note: The lower limit shall apply at the transition frequency.

Page 12 Rev. 00

7.2 TEST PROCEDURE OF LINE CONDUCTED EMISSION

Procedure of Preliminary Test

• The EUT was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.

Date of Issue: August 08, 2005

- Support equipment, if needed, was placed as per EN 55022.
- All I/O cables were positioned to simulate typical actual usage as per EN 55022.
- The test system with EUT received AC power, 230V/50Hz, through a Line Impedance Stabilization Network (LISN), which supplied power source and was grounded to the ground plane.
- All support equipment received power from a second LISN.
- The EUT test program was started. Emissions were measured on each current carrying line of the EUT using an EMI Test Receiver connected to the LISN powering the EUT.
- The Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- During the above scans, the emissions were maximized by cable manipulation.
- The test mode(s) described in Item 3.2 were scanned during the preliminary test.
- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT configuration and cable configuration of the above highest emission level were recorded for reference of the final test.

Procedure of Final Test

- EUT and support equipment were set up on the test bench as per the configuration with highest emission level in the preliminary test.
- A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less –2dB to the Average limit in Q.P. mode, then the emission signal was re-checked using an Average detector.
- The test data of the worst-case condition(s) was recorded.

Page 13 Rev. 00

Data Sample:

Freq. MHz	Read Level dBuV	Factor dB	Level dBuV	Limit dBuV	Over Limit dB	Reading Type (P/Q/A)	Line (L1/L2)
X.XX	42.95	0.55	43.50	73	-29.50	Q	L1

Date of Issue: August 08, 2005

Freq. = Emission frequency in MHz

Read Level = Uncorrected Analyzer/Receiver reading Factor = Insertion loss of LISN + Cable Loss

Level = Read Level + Factor Limit = Limit stated in standard Over Limit = Reading in reference to limit

P = Peak Reading

Q = Quasi-peak Reading A = Average Reading

L1 = Hot side L2 = Neutral side

Calculation Formula

Over Limit (dB) = Level (dBuV) – Limit (dBuV)

7.3 TEST PROCEDURE OF COMMON MODE CONDUCTED EMISSION FOR TELECOMMUNICATION PORT

- Selecting ISN for unscreened cable or a current probe for screened cable to take measurement.
- The port of the EUT was connected to the remote side support equipment through the ISN/Current Probe and communication in normal condition.
- Making a overall range scan by using the test receiver controlled by controller and record at least six highest emissions for showing in the test report.
- Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.
- In case of measuring on the screened cable, the current limit shall be applied, otherwise the voltage limit should be applied.
- The following test mode(s) were scanned during the preliminary test:

N/A

• After the preliminary scan, we found the following test mode(s) producing the highest emission level and test data of the worst case was recorded.

N/A

Page 14 Rev. 00

Data Sample:

Freq. MHz	Read Level dBuV	Factor dB	Level dBuV	Limit dBuV	Over Limit dB	Reading Type (P/Q/A)
x.xx	62.95	0.55	63.50	87	-23.50	Q

Date of Issue: August 08, 2005

Freq. = Emission frequency in MHz

Read Level = Uncorrected Analyzer/Receiver reading Factor = Insertion loss of ISN + Cable Loss

Level = Read Level + Factor Limit = Limit stated in standard Over Limit = Reading in reference to limit

P = Peak Reading

Q = Quasi-peak Reading A = Average Reading

Calculation Formula

Over Limit (dB) = Level (dBuV) – Limit (dBuV)

7.4 TEST PROCEDURE OF RADIATED EMISSION

Procedure of Preliminary Test

- The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
 - Support equipment, if needed, was placed as per EN 55022.
 - All I/O cables were positioned to simulate typical usage as per EN 55022.
 - The EUT received AC power source, 230V/50Hz, from the outlet socket under the turntable. All support equipment received power from another socket under the turntable.
 - Mains cables, telephone lines or other connections to auxiliary equipment located outside the
 test are shall drape to the floor, be fitted with ferrite clamps or ferrite tubes placed on the floor
 at the point where the cable reaches the floor and then routed to the place where they leave the
 turntable. No. extension cords shall be used to mains receptacle.
 - The antenna was placed at 10 meter away from the EUT as stated in EN 55022. The antenna connected to the Spectrum Analyzer via a cable and at times a pre-amplifier would be used.
 - The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.

Page 15 Rev. 00

• The test mode(s) described in Item 3.2 were scanned during the preliminary test:

- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for the final test.

Date of Issue: August 08, 2005

Procedure of Final Test

- EUT and support equipment were set up on the turntable as per the configuration with highest emission level in the preliminary test.
- The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.

Data Sample:

Freq. MHz	Read Level dBuV	Factor dB/m	Level dBuV/m	Limit dBuV/m	Over Limit dB	Reading Type (P/Q/A)	Pol. (H/V)
X.XX	14.0	12.2	26.2	40	-13.8	Q	Н

Freq. = Emission frequency in MHz

Read Level = Uncorrected Analyzer/Receiver reading

Factor = Antenna Factor + Cable Loss + Attenuator (3/6/10dB) – Amplifier Gain

Level = Read Level + Factor
Limit = Limit stated in standard
Over Limit = Reading in reference to limit

P = Peak Reading

Q = Quasi-peak Reading A = Average Reading

H = Antenna Polarization: Horizontal V = Antenna Polarization: Vertical

Calculation Formula

Over Limit (dB) = Level (dBuV/m) – Limit (dBuV/m)

Page 16 Rev. 00

7.5 TEST RESULTS

Line Conducted Emission

Model: ETX-821 Test Mode: Mode 1

Temperature: 25°C Humidity: 47% RH

Test Results: Passed **Tested by:** Sam Hu

(The chart below shows the highest readings taken from the final data, see **Appendix III** for details.)

Date of Issue: August 08, 2005

Six Highest Conducted Emission Readings							
Frequency Range Investigated			150 kHz to 30 MHz				
Read Freq Level Factor Level (MHz) (dBuV) (dB) (dBuV)			Limit Line (dBuV)	Over Limit (dB)	Reading Type (P/Q/A)	Line (L1/L2)	
4.114	34.59	0.34	34.94	73.00	-38.06	P	L1
13.479	32.90	1.04	33.94	73.00	-39.06	P	L1
4.114	34.51	0.40	34.91	73.00	-38.09	P	L2
9.059	29.30	0.81	30.11	73.00	-42.89	P	L2
13.479	32.13	1.19	33.33	73.00	-39.67	P	L2
20.814	30.70	1.74	32.44	73.00	-40.56	P	L2

NOTE: The emission level was or more than 2dB below the Average limit, so no re-check anymore.

Common Mode Conducted Emission

Not applicable.

Page 17 Rev. 00

Radiated Emission

Model: ETX-821 **Test Mode:** Mode 1

Temperature: 30°C **Humidity:** 48% RH

Test Results: Passed **Tested by:** Sam Hu

(The chart below shows the highest readings taken from the final data, see Appendix III for details.)

Date of Issue: August 08, 2005

Six Highest Radiated Emission Readings							
Frequency Range Investigated			30 MHz to 1000 MHz at 10m			0m	
	Read			Limit	Over	Reading	
Freq	Level	Factor	Level	Line	Limit	Type	Pol.
(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	(P/Q/A)	(H/V)
40.030	44.17	-10.58	33.59	40.00	-6.41	P	V
191.863	47.49	-11.82	35.67	40.00	-4.33	P	V
479.653	43.58	-1.58	42.00	47.00	-5.00	P	V
133.330	43.75	-9.98	33.77	40.00	-6.23	P	Н
166.675	44.87	-11.35	33.53	40.00	-6.47	P	Н
200.218	48.03	-11.73	36.30	40.00	-3.70	P	Н

NOTE: None.

Page 18 Rev. 00

8 POWER HARMONICS TEST

Port : AC Power Port

Basic Standard : EN 61000-3-2 (2000)

Limits : CLASS A; CLASS D

Tested by : N/A
Temperature : N/A
Humidity : N/A

Limit:

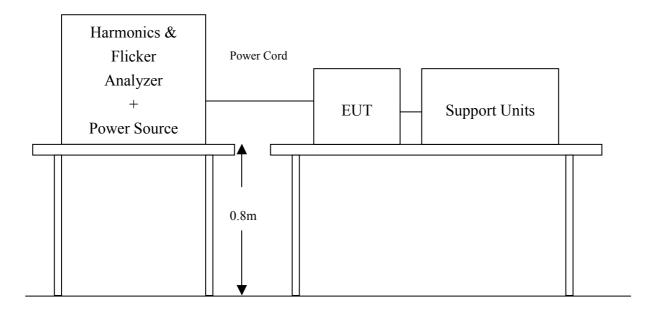
Limits for Class A equipment				
Harmonics	Max. permissible			
Order	harmonics current			
n	A			
Od	d harmonics			
3	2.30			
5	1.14			
7	0.77			
9	0.40			
11	0.33			
13	0.21			
15<=n<=39	0.15x15/n			
Eve	en harmonics			
2	1.08			
4 0.43				
6	0.30			
8<=n<=40	0.23x8/n			

Limits for Class D equipment							
Harmonics	Max. permissible harmonics	Max. permissible					
Order	current per watt mA/W	harmonics current					
n		A					
	Odd Harmonics only	1					
3	3.4	2.30					
5	1.9	1.14					
7	1.0	0.77					
9	0.5	0.40					
11	0.35	0.33					
13	0.30	0.21					
15<=n<=39	3.85/n	0.15x15/n					

Date of Issue: August 08, 2005

Page 19 Rev. 00

Block Diagram of Test Setup:



Test Procedure:

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

Test Result:

☐ PASS	☐ FAIL
Note: According to clause 7 of EN 61000-75W or less, no limits apply. The test result	3-2: 2000, equipment with a rated power of tis only for reference.

Page 20 Rev. 00



POWER VOLTAGE FLUCTUATION / FLICKER TEST

: AC Power Port **Port**

: EN 61000-3-3 (1995 + A1: 2001) **Basic Standard**

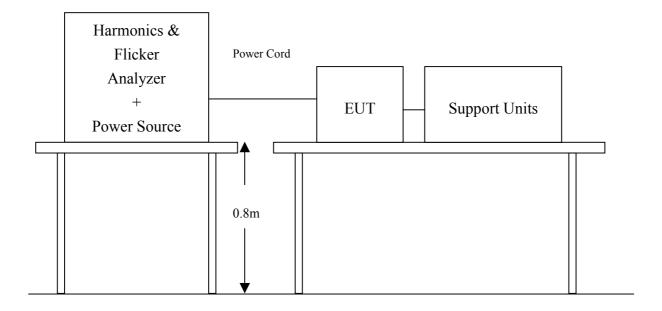
Limits : §5 of EN 61000-3-3

Tested by : Sam Hu : 21°C **Temperature** Humidity : 52%

Limit:

TEST ITEM	LIMIT	REMARK
P_{st}	1.0	P _{st} means short-term flicker indicator.
P _{lt}	0.65	P _{lt} means long-term flicker indicator.
T _{dt} (ms)	500	T _{dt} means maximum time that dt exceeds 3.3 %.
d _{max} (%)	4%	d_{max} means maximum relative voltage change.
dc (%)	3.3%	dc means relative steady-state voltage change

Block Diagram of Test Setup:



Page 21 Rev. 00

Test Procedure:

a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.

Date of Issue: August 08, 2005

b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

Test Result: (See Appendix II for details)

TEST PARAMETER	MEASUREMENT VALUE	LIMIT	RESULT
P_{st}	0.001	1.0	Pass
P_{lt}	0.001	0.65	Pass
T _{dt} (ms)	0.0	500	Pass
d _{max} (%)	0.00	4%	Pass
dc (%)	0.11	3.3%	Pass

Observation: None.

Page 22 Rev. 00

10 ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

Port : Enclosure

Basic Standard: IEC/EN 61000-4-2

Test Level : $\pm 8 \text{ kV (Air Discharge)}$

 \pm 4 kV (Contact Discharge)

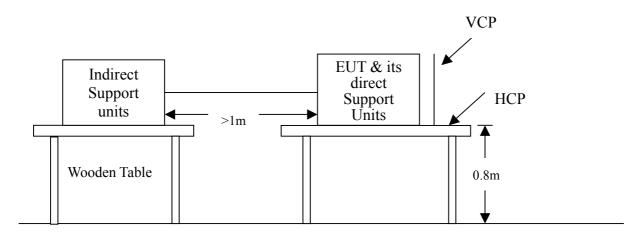
± 4 kV (Indirect Discharge)

Performance Criterion: B (Standard Required)

Tested by : Sam Hu
Temperature : 21°C
Humidity : 52%
Pressure : 1011mbar

Block Diagram of Test Setup:

(The 470 k ohm resistors are installed per standard requirement.)



Ground Reference Plane

Page 23 Rev. 00

Test Procedure:

- 1. The EUT was located 0.1 m minimum from all sides of the HCP.
- 2. The indirect support units were located 1 m minimum away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10 cm with EUT.

Date of Issue: August 08, 2005

- 3. As per the requirement of EN 55024; applying direct contact discharge at the sides other than front of EUT at minimum 50 discharges (25 positive and 25 negative) if applicable, can't be applied direct contact discharge side of EUT then the indirect discharge shall be applied. One of the test points shall be subjected to at least 50 indirect discharge (contact) to the front edge of horizontal coupling plane.
- 4. Other parts of EUT where it is not possible to perform contact discharge then selecting appropriate points of EUT for air discharge, a minimum of 10 single air discharges shall be applied.
- 5. The application of ESD to the contact of open connectors is not required.
- 6. The EUT direct connection units also need to be applied ESD at the port of EUT cable connected.
- 7. Putting a mark on EUT to show tested points. The following test condition was followed during the tests.

Note: As per IEC/EN 61000-4-2, two 470k bleed resistors cable is connected between the EUT and HCP during the test applicable for power ungrounded or battery operating unit only.

The electrostatic discharges were applied as follows:

Amount of discharge	Voltage	Coupling	Result (Pass/Fail)
Mini 10 /Point	$\pm 8 \text{ kV}$	Air Discharge	Pass
Mini 25 /Point	$\pm 4 \text{ kV}$	Contact Discharge	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge HCP (Front)	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge VCP (Right)	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge VCP (Left)	Pass
Mini 25 /Point	± 4 kV	Indirect Discharge VCP (Back)	Pass

Page 24 Rev. 00

Performance & Result:

	Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of
	Criterion B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
	Criterion C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
Oł	oservation:	As \pm 4kV contact discharge applying to screws of EUT, the transmitting was paused during test. It could become normal after test stopped.

Date of Issue: August 08, 2005

Page 25 Rev. 00

11 RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port : Enclosure

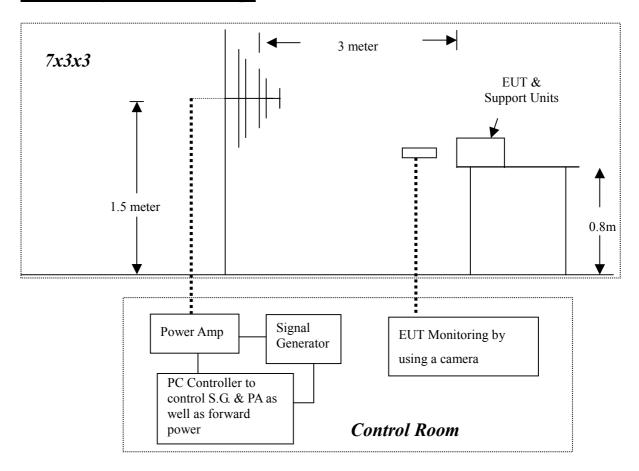
Basic Standard: IEC/EN 61000-4-3

Requirements : 3 V/m / with 80% AM. 1kHz Modulation.

Performance Criterion: A (Standard Required)

Tested by : Sam Hu
Temperature : 21°C
Humidity : 52%
Pressure : 1011mbar

Block Diagram of Test Setup:



Page 26 Rev. 00

Test Procedure:

1. The EUT and support units were located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity.

Date of Issue: August 08, 2005

- 2. Adjusting the cables to be exposed to the electromagnetic filed as possible.
- 3. Performing a Radiated Emission Scan in range of 80 to 1000 MHz prior to do RS test and records the more higher emission frequencies for the reference of RS test, due to antenna effectiveness.
- 4. Adjusting the monitoring camera to monitor the "H" message as clear as possible.
- 5. Setting the testing parameters of RS test software per IEC 61000-4-3.
- 6. Referring to the tested data of step 3 to performing the RS test from 80 to 1000 MHz.
- 7. Recording the test result in following table.
- 8. Changing the EUT to the other side and repeat step 3 to 6, until 4 sides of EUT were verified.

IEC 61000-4-3 Final test conditions:

Test level : 3V/m

Steps : 1 % of fundamental

Dwell Time: 3 sec

Range (MHz)	Field	Modulation	Polarity	Position (°)	Result (Pass/Fail)
80-1000	3V/m	Yes	Н	Front	Pass
80-1000	3V/m	Yes	V	Front	Pass
80-1000	3V/m	Yes	Н	Right	Pass
80-1000	3V/m	Yes	V	Right	Pass
80-1000	3V/m	Yes	Н	Back	Pass
80-1000	3V/m	Yes	V	Back	Pass
80-1000	3V/m	Yes	Н	Left	Pass
80-1000	3V/m	Yes	V	Left	Pass

Page 27 Rev. 00

Performance & Result:

	Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
	Criterion B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
	Criterion C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
Oł	oservation:	No function degraded during the tests.

Date of Issue: August 08, 2005

Page 28 Rev. 00



12 FAST TRANSIENTS/BURST IMMUNITY TEST

Port : AC Power Port and RJ45 Port

Basic Standard : IEC/EN 61000-4-4

: ± 1 kV for AC Power Port Requirements

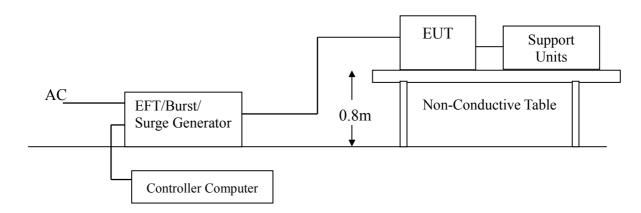
 \pm 0.5 kV for RJ45 Port

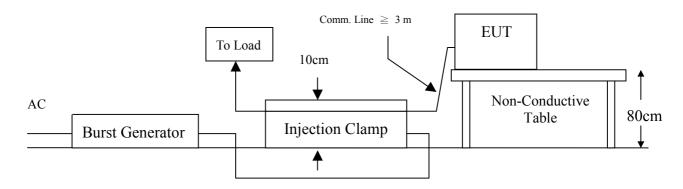
Performance Criteria: B (Standard Required)

Tested by : Sam Hu : 21°C **Temperature** : 52% Humidity

Pressure : 1010mbar

Block Diagram of Test Setup:





Test Procedure:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground reference plane.
- 2. A 1.0 meter long power cord was attached to EUT during the test.
- 3. The length of communication cable between communication port and clamp was keeping within 1 meter.
- 4. Injected test voltage to the EUT ports from minimum to standard request or client request.
- 5. Recorded the test result as shown in following table.

Page 29 Rev. 00

Test conditions:

Impulse Frequency: 5kHz
Tr/Th: 5/50ns
Burst Duration: 15ms
Burst Period: 300ms

Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L	± 1	Direct	Pass
N	± 1	Direct	Pass
PE	± 1	Direct	Pass
L+N	± 1	Direct	Pass
L + PE	± 1	Direct	Pass
N + PE	± 1	Direct	Pass
L + N + PE	± 1	Direct	Pass
RJ45	± 0.5	Clamp	Pass

Performance & Result:

	Criterion A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
	Criterion B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
	Criterion C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.
Ol	oservation:	As \pm 1 kV applied on line-neutral of AC power port and \pm 0.5 kV on RJ-45 port, the transmitting was paused during test. It could become normal after test stopped.

Page 30 Rev. 00

Date of Issue: August 08, 2005

13 SURGE IMMUNITY TEST

Port : AC Power Port and RJ45 Port

Basic Standard: IEC/EN 61000-4-5

Requirements : $\pm 1 \text{ kV}$ (Line to Line) for AC Power Port

± 2 kV (Line to Ground) for AC Power Port

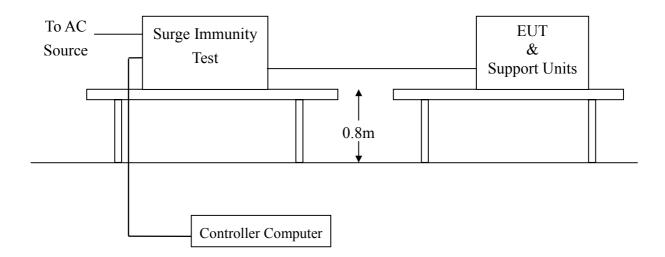
Date of Issue: August 08, 2005

Performance Criteria: B (Standard Required)

Tested by : Sam Hu
Temperature : 21°C
Humidity : 52%

Pressure : 1011mbar

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table 0.8 m away from ground floor.
- 2. Injected test voltage to the EUT ports from minimum to standard request or client request.
- 3. Recorded the test result as shown in following table.

Page 31 Rev. 00

Test conditions:

Voltage Waveform : 1.2/50 us Current Waveform : 8/20 us

Polarity : Positive/Negative Phase angle : 0°, 90°, 270°

Number of Test : 5

Coupling Line	Voltage (kV)	Polarity	Coupling Method	Result (Pass/Fail)
L1-L2	1	Positive	Capacitive	Pass
L1-PE	2	Positive	Capacitive	Pass
L2-PE	2	Positive	Capacitive	Pass
L1-L2	1	Negative	Capacitive	Pass
L1-PE	2	Negative	Capacitive	Pass
L2-PE	2	Negative	Capacitive	Pass

Performance & Result:

EUT, no test be required.

	Criterion A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.		
		The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. Temporary loss of function is allowed, provided the functions self	
		recoverable or can be restored by the operation of controls.	
Ob	servation:		
	_	applied on line-ground of AC power port, the transmitting was paused ould become normal after test stopped.	
2. V	Where normal f	functioning of LAN can't be achieved because of the impact of CDN on the	

Page 32 Rev. 00

Date of Issue: August 08, 2005

14 CONDUCTED DISTRBANCE/INDUCED RADIO-FREQUENCY FIELD IMMUNITY TEST

Port : AC Power Port and RJ45 Port

Basic Standard: IEC/EN 61000-4-6

Requirements : 3 V, with 80% AM. 1kHz Modulation.

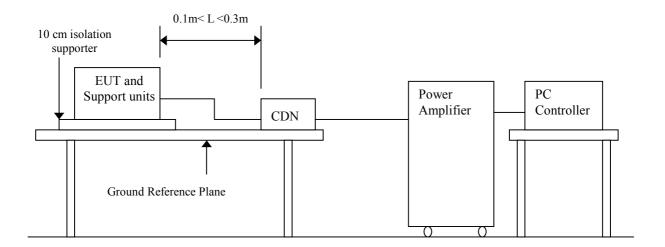
Injection Method : CDN-M3 for AC Power Port

CDN-T4 for RJ45 Port

Performance Criterion: A (Standard Required)

Tested by : Sam Hu
Temperature : 21°C
Humidity : 52%
Pressure : 1011mbar

Block Diagram of Test Setup:

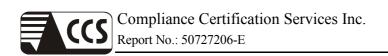


Test Procedure:

- 1. The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
- 2. Set the testing parameters of CS test software as per IEC/EN 61000-4-6.
- 3. Recorded the test result in following table.

Page 33 Rev. 00

Date of Issue: August 08, 2005



Test conditions:

Frequency Range : 0.15MHz-80MHz Frequency Step : 1% of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Result (Pass/Fail)
0.15-80	3V	Yes	Pass

Date of Issue: August 08, 2005

Performance & Result: Criterion A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. Criterion C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls. |X PASS **FAIL Observation:** No function degraded during the tests.

Page 34 Rev. 00

15 POWER FREQUENCY MAGNETIC FIELD IMMUNITY **TEST**

Date of Issue: August 08, 2005

Port : Enclosure

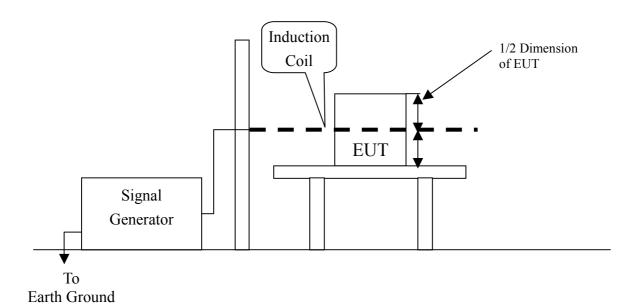
: IEC/EN 61000-4-8 **Basic Standard**

: 1 A/m **Requirements**

Performance Criterion: A (Standard Required)

Tested by : N/A **Temperature** : N/A Humidity : N/A **Pressure** : N/A

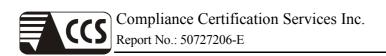
Block Diagram of Test Setup:



Test Procedure:

- The EUT and support units were located on Ground Reference Plane with the interposition of a 0.1 m thickness insulation support.
- 2. Put the induction coil on horizontal direction. (X direction)
- 3. Recorded the test result as shown in following table.
- 4. Rotated the induction coil by 90° (Y direction) then repeat step 3.
- Rotated the induction coil by 90° (Z direction) then repeat step 3.

Page 35 Rev. 00



Test conditions:

Field Strength: 1A/m Power Freq.: 50Hz Orientation: X, Y, Z

Orientation	Field	Result (Pass/Fail)	Remark

Date of Issue: August 08, 2005

Performance & Result:			
	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of		
	performance.		

Criterion B:	The apparatus continues to operate as intended after the test. No
	degradation of performance or loss of function is allowed below a
	performance level specified by the manufacturer, when the apparatus is
	used as intended. In some cases the performance level may be replaced
	by a permissible loss of performance. During the test, degradation of
	performance is however allowed.

Criterion C:	Temporary loss	s of function is a	llowed,	provided the	functions	self
1	recoverable or c	an be restored by	y the op	eration of co	ntrols.	

PASS FAIL
Observation: The EUT is not containing any component that is susceptible to a 50 Hz or

60 Hz magnetic field. Therefore, this requirement is not applicable to the EUT.

Page 36 Rev. 00

Report No.: 50727206-E

16 VOLTAGE DIPS / SHORT INTERRUPTIONS

AC Power Port Port Basic Standard IEC/EN 61000-4-11

Requirement PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees

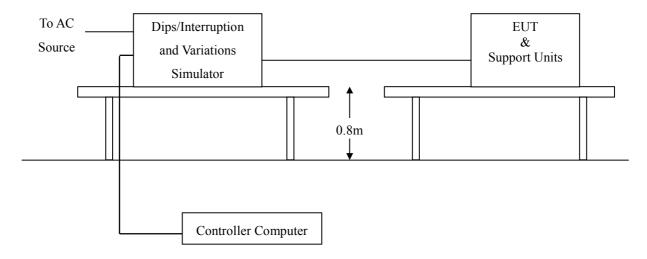
Date of Issue: August 08, 2005

Test Interval Min. 10 sec. **Tested by** Sam Hu 21°C **Temperature** Humidity 52% **Pressure** 1011mbar

Voltage Dips	Test Level % U _T	Reduction (%)	Duration (periods)	Performance Criterion	
	<5	>95	0.5	В	
	70	30	25	C	

Voltage Interruptions	Test Level % U _T	Reduction (%)	Duration (periods)	Performance Criterion
	<5	>95	250	С

Block Diagram of Test Setup:



Test Procedure:

- 1. The EUT and support units were located on a wooden table, 0.8 m away from ground
- Set the parameter of tests and then Performed the test software of test simulator.
- 3. Changed Condition to occur at 0 degree crossover point of the voltage waveform.
- 4. Recorded the test result in test record form.

Page 37 Rev. 00

Test conditions:

The duration with a sequence of three dips/interruptions with interval of 10 sec. minimum (Between each test event)

Date of Issue: August 08, 2005

Voltage Dips:

Test Level % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criterion	
0	100	0.5	Normal	В	
70	30	25	Normal	В	

Voltage Interruptions:

Test Lev % U _T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criterion
0	100	250	EUT shut down, but can be auto recovered as the events disappear.	С

Note: "Normal" means no any functions degrade during and after the test.

Performance & Result:

Criterion A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

Criterion B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a

degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of

performance is however allowed.

Criterion C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

	☐ FAIL
Observation: The transmitting was paused stopped.	during test and became normal after test

Page 38 Rev. 00

APPENDIX I - PHOTOGRAPHS OF TEST SETUP

LINE CONDUCTED EMISSION TEST (EN 55022)





Page 39 Rev. 00

RADIATED EMISSION TEST





Page 40 Rev. 00

POWER HARMONIC & VOLTAGE FLUCTUATION / FLICKER TEST





Page 41 Rev. 00

ELECTROSTATIC DISCHARGE TEST



RADIATED ELECTROMAGNETIC FIELD TEST



Page 42 Rev. 00

FAST TRANSIENTS/BURST TEST



FAST TRANSIENTS/BURST TEST (IEC 61000-4-4 FOR I/O)



Page 43 Rev. 00

SURGE IMMUNITY TEST



CONDUCTED DISTURBANCE, INDUCED BY RADIO-FREQUENCY FIELDS TEST



Page 44 Rev. 00

CONDUCTED DISTURBANCE, INDUCED BY RADIO-FREQUENCY FIELDS TEST (IEC 61000-4-6 FOR I/O)



VOLTAGE DIPS / INTERRUPTION TEST

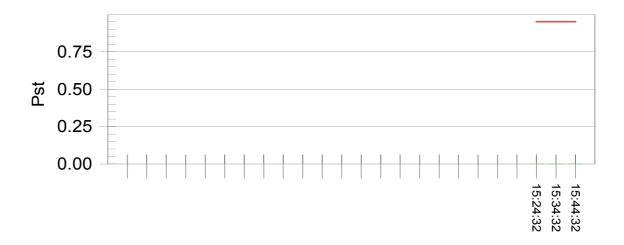


Page 45 Rev. 00

APPENDIX II – TEST RESULT OF EN 61000-3-3

Test Result: Pass Status: Test Completed

Pst_i and limit line European Limits



Time is too short for Plt plot

Parameter values recorded during the test:

Vrms at the end of test (Volt):	229.91			
Highest dt (%):	0.00	Test limit (%):	3.14	Pass
Time(mS) > dt:	0.0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.11	Test limit (%):	3.14	Pass
Highest dmax (%):	0.00	Test limit (%):	3.80	Pass
Highest Pst (10 min. period):	0.001	Test limit:	0.950	Pass
Highest Plt (2 hr. period):	0.001	Test limit:	0.617	Pass

Page 46 Rev. 00

APPENDIX III - TEST RESULT OF FINAL DATAS

Conducted Emission Plot

Date of Issue: August 08, 2005

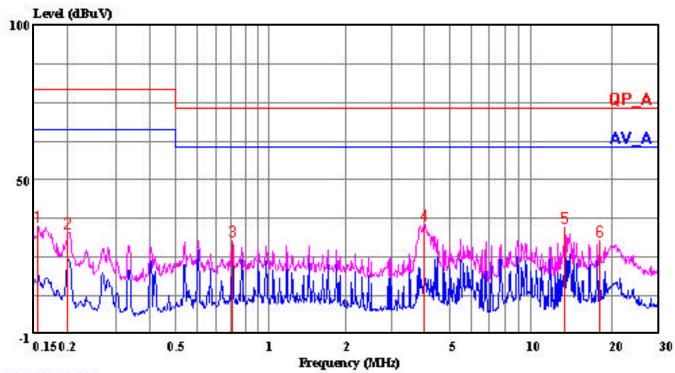
Radiated Emission Data

Page 47 Rev. 00



Tel:02-2217-0894 Fax:02-2217-1029

Data#: 12 File#: 50727206MA.EMI Date: 2005-07-30 Time: 16:58:32



(Conduction A)

Trace: 11 10 Ref Trace:

Condition: LINE

Report No. : 50727206 Test Engr. : SAM HU

Company : AAEON Technology Inc.

EUT : ETX-821

Test Config : EUT / ALL PERIPHERALS
Type of Test: EN 55022 CLASS A
Mode of Op. : NORMAL MODE

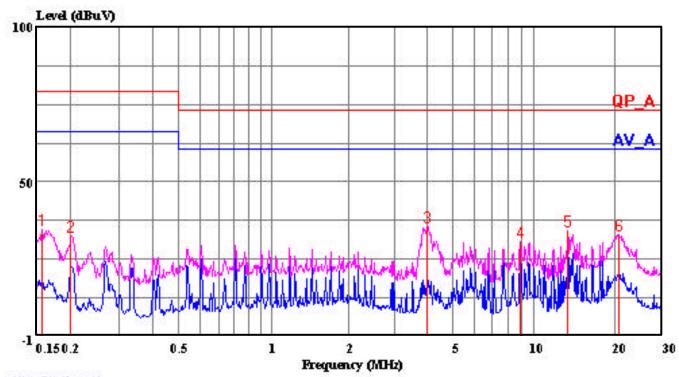
	Page: 1
--	---------

		Read			Limit	Over	
	Freq	Level	Factor	Level	Line	Limit	Remark
	MHz	dBuV	dB	dBuV	dBuV	dB	
1	0.156	34.19	0.14	34.33	79.00	-44.67	Peak
2	0.201	32.27	0.14	32.41	79.00	-46.59	Peak
3	0.804	29.40	0.21	29.61	73.00	-43.39	Peak
4	4.114	34.59	0.34	34.94	73.00	-38.06	Peak
5	13.479	32.90	1.04	33.94	73.00	-39.06	Peak
6	18.135	28.44	1.35	29.79	73.00	-43.21	Peak



Tel:02-2217-0894 Fax:02-2217-1029

Data#: 9 File#: 50727206MA.EMI Date: 2005-07-30 Time: 16:48:56



(Conduction A)

Trace: 8 7 Ref Trace:

Condition: NEUTRAL
Report No. : 50727206
Test Engr. : SAM HU

Company : AAEON Technology Inc.

EUT : ETX-821

Test Config : EUT / ALL PERIPHERALS
Type of Test: EN 55022 CLASS A
Mode of Op. : NORMAL MODE

Page:	1	1
-------	---	---

		Read			Limit	Over	
	Freq	Level	Factor	Level	Line	Limit	Remark
	MHz	dBuV	dВ	dBuV	dBuV	dВ	
1	0.157	33.77	0.13	33.90	79.00	-45.10	Peak
2	0.201	31.60	0.13	31.73	79.00	-47.27	Peak
3	4.114	34.51	0.40	34.91	73.00	-38.09	Peak
4	9.059	29.30	0.81	30.11	73.00	-42.89	Peak
5	13.479	32.13	1.19	33.33	73.00	-39.67	Peak
6	20.814	30.70	1.74	32.44	73.00	-40.56	Peak



Tel:02-2217-0894 Fax:02-2217-1029

Data#: 4 File#: 50727206I.EMI Date: 2005-08-01 Time: 13:52:31

Site#I

Condition: VERTICAL /10M Report No. : 50727206 Test Engr. : SAM SU

Company : AAEON Technology Inc.

EUT : ETX-821

Test Config : EUT / ALL PERIPHERALS

Type of Test: EN 55022 CLASS A

Mode of Op. : NORMAL MODE

Page: 1

	Freq	Read Level	Factor	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dBuV/m	dBuV/m	dB	
1	40.030	44.17	-10.58	33.59	40.00	-6.41	Peak
2	133.353	42.72	-9.98	32.74	40.00	-7.26	Peak
3	140.735	43.06	-10.24	32.82	40.00	-7.18	Peak
4	166.668	44.27	-11.35	32.93	40.00	-7.08	Peak
5	191.863	47.49	-11.82	35.67	40.00	-4.33	Peak
6	479.653	43.58	-1.58	42.00	47.00	-5.00	Peak



Tel:02-2217-0894 Fax:02-2217-1029

Data#: 2 File#: 50727206I.EMI Date: 2005-08-01 Time: 14:17:20

Site#I

Condition: HORIZONTAL /10M Report No. : 50727206 Test Engr. : SAM SU

Company : AAEON Technology Inc.

EUT : ETX-821

Test Config : EUT / ALL PERIPHERALS

Type of Test: EN 55022 CLASS A

Mode of Op. : NORMAL MODE

Page: 1

	Freq	Read Level	Factor	Level	Limit Line	Over Limit	Remark
_	MHz	dBuV	dB	dBuV/m	dBuV/m	dB	
1 2 3 4 5	49.310 133.330 166.675 200.218 233.345 240.030	43.75 44.87 48.03 42.16	-14.44 -9.98 -11.35 -11.73 -9.16 -8.63	32.80 33.77 33.53 36.30 33.00	40.00 40.00 47.00	-7.20 -6.23 -6.47 -3.70 -14.00	Peak Peak Peak Peak